

Search Notes

Application/Control No.

10/780,776

Examiner

Luan K. Bui

Applicant(s)/Patent under
Reexamination

DANIEL, JEAN-YVES

Art Unit

3728

SEARCHED

Class	Subclass	Date	Examiner
206	145, 147	7/27/2005	LKB.
	148, 149		
	152, 153		
	155, 157		
	160, 161		
	427, 434		
294	87.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR